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| Notice of References Cited | Application/Control No. 10/815,577 | Applicant(s)/Patent Under Reexamination WITTMANN ET AL. | |
| | Examiner Kevin Quarterman | Art Unit 2879 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | A | US-6,605,893 B2 | 08-2003 | Ando, Tomokazu | 313/495 |
| * | B | US-6,850,006 B2 | 02-2005 | Kim et al. | 313/512 |
| * | C | US-4,810,931 A | 03-1989 | McKenna et al. | 313/509 |
| * | D | US-6,262,531 B1 | 07-2001 | Inoguchi et al. | 313/506 |
| * | E | US-6,049,167 A | 04-2000 | Onitsuka et al. | 313/512 |
| * | F | US-6,624,572 B1 | 09-2003 | Kim et al. | 313/512 |
| * | G | US-6,888,307 B2 | 05-2005 | Silvernail et al. | 313/512 |
| * | H | US-6,936,131 B1 | 08-2005 | McCormick et al. | 156/292 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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